#### **Test Report Prepared By:**

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MPBT Report No.: M34R2460

Customer No.: PO# 208

**Report for** 

## FCC Part 1 .1310 MPE FCC Part 15 Subpart B FCC Part 90 Subpart I

# For Private Mobile Transmitter Amplifiers for T.D.M.A. Cellular Radio-Telephone Service

## Testing of the BST301 *iDEN* Motorola Truncking Booster

Test Personnel: D.Beck

Prepared for:

Mobile Communications Technologies INC. 360 Industrial Parkway South, Unit #1 Aurora, ON L4G 3V7

February 23, 2001 M34R2197 Client Acceptance Authorized Signatory

Dan Zanette Lab Supervisor Electromagnetic Services Electromagnetics Division Authorized Signatory

MPB Technologies Inc. M34R2460









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#### **1.0 INTRODUCTION**

#### 1.1 SCOPE

The purpose of this report is to present the findings and results of compliance testing performed in accordance with FCC Part(s) 1, 15, 90 (1996).

#### 1.2 APPLICANT

This test report has been prepared for MCT Inc.

#### 1.3 APPLICABILITY

All test procedures, limits, and results defined in this document apply to the, which shall be referred to herein as the Equipment Under Test (**EUT**).

The results contained in this report relate only to the item(s) tested.

## This report does not imply product endorsement by NVLAP or the Canadian or US governments.

If multiple units, the test samples provided for testing were intended for use together.

### 1.4 TEST SAMPLE DESCRIPTION

The following testing is for a Mobile Motorola *iDEN* Truncking Booster

Product	Part Number	Serial Number	Power Requirements	Peripheral Equipment
BST301 <i>iDEN</i> Motorola Truncking Booster	BST 301 (Sample# 1758)		12 VDC	Signal Generator/ Cellular Phone

Tx Gain (dB): 22.0

Measured at: 813.5 MHz

Tx Maximum Power Output (dBm): 34.77 = 3 Watts

Band of operation Tx: 806-821 MHz

Measured at: 813.5 MHz

Rx Gain (dB): 19.0

Measured at: 858.5MHz

Band of operation Rx: 851 - 866 MHz

### 1.5 GENERAL TEST CONDITIONS AND ASSUMPTIONS

The EUT was setup and exercised using the configurations, modes of operation and arrangements defined in this report only. All inputs and outputs to and from other equipment associated with the EUT were adequately simulated.

Where relevant, the EUT was only tested using the monitoring methods and test criteria defined in this report.

All testing, unless otherwise noted, was performed under the following environmental conditions:

Temperature:	17 to 23 °C
Humidity:	45 to 75 %
Barometric Pressure:	68 to 106 kPa

## 1.6 SCOPE OF TESTING

Tests were performed in accordance with FCC Parts 1,15,90 (1996).

## **1.6.1 VARIATIONS IN TEST METHODS**

There were no variations from the test procedures outlined above.

#### **1.6.2 TEST SAMPLE MODIFICATIONS**

No test sample modifications were made

#### 2.0 TEST CONCLUSION

The EUT was subjected to the following tests. Compliance status is assessed as **PASS**, **FAIL**, or **MARGINAL PASS** 

The following table summarizes the test results and details the tests performed in terms of the specification and class or level applied, the unique test sample identification, and the EUT modification state, the mode of operation, and configuration.

Test Case	Test Type	Specification	Class/ Level	Criteria	Test Sample	Config	Engineering / Qualification	Result
2.1	DC Port Conducted Emissions	FCC Part 15, (Subpart B)	В	NA	Sample #1758	Test	Qualification	PASS
2.2	Radiated Emissions (Field Strength Spurious)	FCC Part 15, (Subpart B)	В	NA	Sample #1758	Test	Qualification	PASS
2.3	ERP	FCC Part 22 (Subpart H)	NA	NA	Sample #1758	Test	Qualification	PASS
2.4	Emission Mask (OCC BW)	FCC Part 90	65.4 dB	NA	Sample #1758	Test	Qualification	PASS
2.5	Emission Mask (Out of band/Spurious)	FCC Part 90.210 (Subpart I)	58.4 dB	NA	Sample #1758	Test	Qualification	PASS
2.6	MPE	FCC Part 1.1310	В	NA	Sample #1758	Test	Qualification	PASS

#### STATEMENT OF COMPLIANCE

The client equipment referred to in this report was found to comply with the requirements of FCC regulations as summarized above.

#### ABBREVIATIONS

CE – Conducted Emissions	N/T - Not Tested
E-Field - Electric Field	N/A - Not Applicable
H-Field - Magnetic Field	RE – Radiated Emissions

#### MEASUREMENT UNCERTAINTY

The following measurement uncertainty with 95% confidence level was calculated using the methods defined in NAMAS document NIS81: May 1994.

For Radiated E-Field Emissions Frequency  $= \pm 1 \times 10^{-3}$  MHz Amplitude  $= \pm 4.01$  dB

For Conducted Emissions

Frequency  $= \pm 1 \times 10^{-3}$  MHz Amplitude  $= \pm 3.25$  dB

TEST SET UP

The photographs in Appendix D show the set up with maximized emission levels for each test.

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## 2.1 EMISSIONS – AC PORT CONDUCTED

Test Summary		
Test Lab: MPB Technologies Inc. Ottawa	Product: BST301 <i>iDEN</i> Motorola	
Test Personnel: D. Beck	Truncking Booster	
Test Date: February 7, 2000		

Test Description			
Objectives/Criteria	Specifications		
The Conducted E-Field emissions proliferated by a system or sub-system shall not exceed the limits for the specifications as stated. <b>Emission levels should meet the</b>	FCC PART 15: 1996           Frequency         Class A*         Class B*           .45 – 1.705 MHz         60         48           1.705 – 30 MHz         69.5         48		
The EUT was tested against <u>Class B</u> limits.	*All limits are for Quasi-peak detection in dBµV. The detector bandwidth is 9 kHz.		

Test Result: PASS	
Comments: Refer to Test Report Data sheets for more detail.	

## 2.2 DIGITAL EMISSIONS, RADIATED

## FIELD STRENGTH SPURIOUS

Test Summary		
Test Lab: MPB Technologies Inc. Ottawa	Product: BST301 <i>iDEN</i> Motorola	
Test Personnel: D. BECK	Truncking Booster	
Test Date: February 7, 2001		

Test Description				
Objectives/Criteria	Specifications			
The Radiated E-Field emissions proliferated by	FCC Part 15: 1996			
a system or sub-system, measured at a distance	Frequency Class A* Class B*			
of 3m from the EUT, shall not exceed the limits for the specifications as stated.	30 - 88 MHz 49.5 40.0			
Emission levels should meet the	88 – 216 MHz 54.0 43.5			
requirements with a margin of 6dB.	216 – 960 MHz 56.9 46.0			
The EUT was tested against Class B	> 960 MHz 60.0 54.0			
requirements	*All limits are @ 3m and are in $dB\mu V/m$ .			

## Test Result: PASS

No spurious or digital emissions were detected. Refer to Test Report Data sheets for more detail.

## 2.3 EFFECTIVE RADIATED POWER (ERP) LIMIT (Supplementary Data)

Test Summary		
Test Lab: MPB Technologies Inc. Ottawa	Product: BST301 <i>iDEN</i> Motorola	
Test Personnel: D. BECK	Truncking Booster	
Test Date: February 7, 2001		

Test Description		
Objectives/Criteria	Specifications	
The ERP proliferated by a system or sub- system shall not exceed the limits for the specifications as stated.	FCC PART 90: 1996, Subpart H Section 90.219 Limit = 5 Watts Limit = 36.99 dBm Max Power = 34.77 dBm / 3.0Watts ERP: Power <sub>AMP</sub> -Loss <sub>Cable</sub> +Gain <sub>Ant</sub> ERP= 34.77dB-3.6dB+5dB= 36.17dBm or 4.14 Watts	

Test Result: PASS	
Comments: Refer to Test Report Data sheets for more detail.	

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## 2.4 EMISSION LIMITATIONS FOR CELLULAR – OCCUPIED BANDWIDTH

Test Summary		
Test Lab: MPB Technologies Inc. Ottawa	Product: BST301 <i>iDEN</i> Motorola	
Test Personnel: D. BECK	Truncking Booster	
Test Date: February 7, 2001		

Test Description		
Objectives/Criteria	Specifications	
<ul> <li>For an F3E/F3D emission mask, the mean power of emissions must be attenuated below that specified in mask (b), or mask (c). Measurement bandwidths are to be 300 Hz for any frequency removed from the carrier less then 45 kHz and 30 kHz for all else. For equipment which does not perform modulation and only amplifies the RF signal, pass/fail criteria shall be based on the following:</li> <li>a) The 20 dB bandwidth of the modulated carrier shall be the same (input signal vs. output signal).</li> <li>b) The difference of the amplitudes between the input signal and the output signal shall remain consistent (+/- 0.5 dB), for the 20 dB bandwidth of the modulated carrier.</li> </ul>	FCC PART 90: 1996, Subpart H Section 90.211(b)/(c)Mask (b) $(f_c - 45 \text{ kHz})$ to $(f_c - 20 \text{ kHz})$ , 26 dB $(f_c + 20 \text{ kHz})$ to $(f_c + 45 \text{ kHz})$ , 26 dB0 to $(f_c - 45 \text{ kHz})$ , 60 or 43 + 10logP dB $(f_c + 45 \text{ kHz})$ to $(2 \text{ x } f_c)$ , 60 or 43 + 10logP dB $(f_c + 45 \text{ kHz})$ to $(2 \text{ x } f_c)$ , 60 or 43 + 10logP dBMask (c) $(f_c - 20 \text{ kHz})$ to $(f_c - 12 \text{ kHz})$ , 117log(f_d/12) dB $(f_c + 12 \text{ kHz})$ to $(f_c + 20 \text{ kHz})$ , 117log(f_d/12) dB0 to $(f_c - 20 \text{ kHz})$ , 100log(f_d/12) or 60 or 43 + 10logPdB $(f_c + 20 \text{ kHz})$ to $(2 \text{ x } f_c)$ , 100log(f_d/12) or 60 or 43+10logP dBNote: dB refers to attenuation from the mean power of the unmodulated carrier. $f_c$ refers to frequency of the carrier $f_d$ refers to displacement frequency from the carrier in kHzP refers to the mean power of unmodulated carrier wave.	

## Test Result: PASS

Comments:

Refer to Test Report Data sheets for more detail.

MPB Technologies Inc. M34R2197